

Issue Classification

Application/Control No.

10020240

Applicant(s)/Patent Under Reexamination

TANAKA ET AL.

Examiner

Nguyen, My X

Art Unit

2617

ORIGINAL

INTERNATIONAL CLASSIFICATION

CLASS

SUBCLASS

CLAIMED

NON-CLAIMED

455

414.1

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3 / 42 (2006.0)

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

348

552

Nguyen, My X

09/19/2007

(Assistant Examiner)

(Date)

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Total Claims Allowed:

6

(Legal Instruments Examiner)

(Date)

Rafael Perez-Gutierrez

(Primary Examiner)

9/20/07

(Date)

O.G. Print Claim(s).

12

O.G. Print Figure

4 and 6